

**Search Notes**

Application/Control No.

10/561,957

Examiner

SEYED MASOUD  
MALEKZADEHApplicant(s)/Patent under  
Reexamination

NISHIZAWA, TSUYOSHI

Art Unit

1722

**SEARCHED**

Class	Subclass	Date	Examiner
438	455	3/28/2007	SMM
438	149	3/28/2007	SMM
438	155	3/29/2007	SMM
257	758	3/29/2007	SMM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Use Palm Intranet to search inventor's name	3/28/2007	SMM
Use text search through East to find patents related to the application Examiner used key words such "silicon wafer"	3/28/2007	SMM